Form PTO 1449 (Modified)		U.S. DEPARTMENT O PATENT AND TRADE	OF COMMERCE EMARK OFFICE	ATTY DOCKET NO. 213559US2		SERIAL NO. NEW APPLICATION		
LIST OF	REFE	RENCES CITED BY APP	PLICANT	APPLICANT Hideki OHTSUKI				
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				U.S. PATENT DOCUMEN	TS	<u></u>		
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Examiner		V. Kos Jule			Date Cor	nsidered	6-10	7-05
*Examiner: Init	tial if re	aference is considered, w	vhether or not	citation is in conformance with next communication t	with MPEP 609; Draw I	ine through	citation i	if not in